


<b>Search Notes</b>  	<b>Application/Control No.</b>  10612097	<b>Applicant(s)/Patent Under Reexamination</b>  ECKHART ET AL.
	<b>Examiner</b>  JAMES RUTTEN	<b>Art Unit</b>  2192

### SEARCHED

Class	Subclass	Date	Examiner
717	127	3/14/08	/jdr/

### SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout		
Google - www.google.com - see search history printout	3/10/08	/jdr/
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout		
ACM - portal.acm.org		
IEEE - ieeexplore.ieee.org	3/11/08	/jdr/
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout		
717/127; 710/260; 712/244 - text search - see search history printout	3/14/08	/jdr/
Tuan Dam (consulted re. Allowable subject matter)	3/13/08	/jdr/

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
717	127		
710	260		
712	244	3/14/08	/jdr/